

<b>Notice of References Cited</b>	Application/Control No. 10/038,169	Applicant(s)/Patent Under Reexamination BONEH ET AL.	
	Examiner Baotran N. To	Art Unit 2135	Page 1 of 1

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*	B	US-7,152,244 B2	12-2006	Toomey, Christopher	726/26
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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